

1200V/600A 2 in one-package

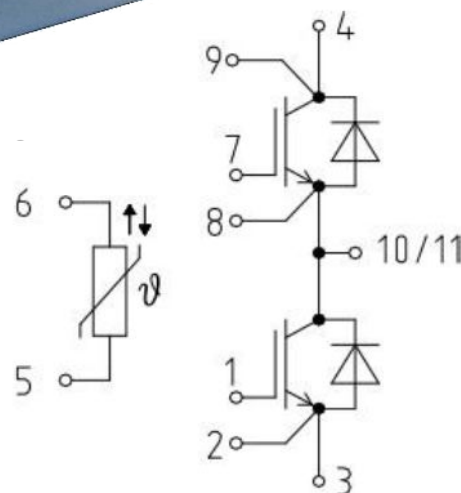
Features:

- 1200V600A, $V_{CE(sat)}(typ.) = 2.20V$
- Lower losses and higher energy
- Excellent short circuit ruggedness
- Standard Housing



General Applications:

IGBTs offer lower losses and higher energy for application such as motor drive, inverter and other



Absolute Maximum Ratings of IGBT

V_{CES}	Collector to Emitter Voltage		1200	V
V_{GES}	Continuous Gate to Emitter Voltage		± 30	V
I_C	Continuous Collector Current	$T_C = 25^\circ C$	1000	A
		$T_C = 100^\circ C$	600	
I_{CM}	Pulse Collector Current	$T_J = 150^\circ C$	1200	A
P_D	Maximum Power Dissipation (IGBT)	$T_C = 25^\circ C$, $T_J = 150^\circ C$	3680	W
t_{sc}	Short Circuit Withstand Time		> 10	μs
T_J	Maximum IGBT Junction Temperature		150	$^\circ C$
T_{JOP}	Maximum Operating Junction Temperature Range		-40 to +150	$^\circ C$
T_{stg}	Storage Temperature Range		-40 to +125	$^\circ C$

Absolute Maximum Ratings of Freewheeling Diode

V_{RRM}	Repetitive Peak Reverse Voltage Preliminary Data		1200	V
I_F	Diode Continuous Forward Current	$T_C = 25^\circ C$	1200	A
	Diode Continuous Forward Current	$T_C = 100^\circ C$	600	
I_{FM}	Diode Maximum Forward Current		1200	A

Electrical Characteristics of IGBT at $T_J = 25^\circ\text{C}$ (Unless Otherwise Specified)

Parameter	Test Conditions	Min	Typ	Max	Unit
BV_{CES}	Collector to Emitter Breakdown Voltage $V_{GE} = 0V, I_C = 1mA$	1200			V
I_{CES}	Collector to Emitter Leakage Current $V_{GE} = 0V, V_{CE} = V_{CES}$			3	mA
I_{GES}	Gate to Emitter Leakage Current $V_{GE} = \pm 30V, V_{CE} = 0V$			400	nA
$V_{GE(th)}$	Gate Threshold Voltage $I_C = 2.5mA, V_{CE} = V_{GE}$	5.0		6.0	V
$V_{CE(sat)}$	Collector to Emitter Saturation Voltage (Module Level) $I_C = 600A, V_{GE} = 15V$	$T_J = 25^\circ\text{C}$	2.20	2.40	V
		$T_J = 125^\circ\text{C}$	2.40		

Switching Characteristics of IGBT

$t_{d(on)}$	Turn-on Delay Time	$V_{CC} = 600V$ $I_C = 600A$ $R_G = 1.5\Omega$ $V_{GE} = \pm 15V$ Inductive Load	$T_J = 25^{\circ}C$		232		ns
t_r	Turn-on Rise Time		$T_J = 25^{\circ}C$		240		ns
$t_{d(off)}$	Turn-off Delay Time		$T_J = 25^{\circ}C$		1210		ns
t_f	Turn-off Fall Time		$T_J = 25^{\circ}C$		385		ns
E_{on}	Turn-on Switching Loss		$T_J = 25^{\circ}C$		60.0		mJ
E_{off}	Turn-off Switching Loss		$T_J = 25^{\circ}C$		128.0		mJ
Q_g	Total Gate Charge		$T_J = 25^{\circ}C$		5000		nC
R_{gint}	Integrated gate resistor	$f = 1M;$ $V_{pp} = 1V$	$T_J = 25^{\circ}C$		1.6		Ω
C_{ies}	Input Capacitance	$V_{CE} = 25V$ $V_{GE} = 0V$ $f = 1MHz$	$T_J = 25^{\circ}C$		42		nF
C_{oes}	Output Capacitance		$T_J = 25^{\circ}C$		5.0		
C_{res}	Reverse Transfer Capacitance		$T_J = 25^{\circ}C$		3.2		
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case (IGBT)					0.034	$^{\circ}C/W$

Electrical and Switching Characteristics of Freewheeling Diode

V _F	Diode Forward Voltage	I _F = 600A, V _{GE} = 0V	T _J = 25°C		2.20		V
			T _J = 125°C		2.20		
I _{rr}	Diode Peak Reverse Recovery Current	I _F = 600A, di/dt = 5000A/μs, V _{rr} = 600V,	T _J = 25°C		210		A
Q _{rr}	Diode Reverse Recovery Charge		T _J = 25°C		11.1		uC
E _{rec}	Diode Reverse Recovery Energy		T _J = 25°C		11.0		mJ
R _{θJC}	Thermal Resistance, Junction-to-Case (Diode)					0.07	°C/W

NTC-Thermistor Characteristic Values

R_{25}	$T_C = 25^\circ C$	5		k Ω
$\Delta R/R$	$T_C = 100^\circ C$, $R_{100} = 481\Omega$		± 5	%
P_{25}	$T_C = 25^\circ C$	50		mW
$B_{25/50}$	$R_2 = R_{25} \exp[B_{25/50}(1/T_2 - 1/(298.15K))]$	3380		K
$B_{25/80}$	$R_2 = R_{25} \exp[B_{25/80}(1/T_2 - 1/(298.15K))]$	3440		K

Module Characteristics

Parameter		Min.	Typ.	Max.	Unit
V_{iso}	Isolation Voltage (All Terminals Shorted), $f = 50Hz$, 1minute	2500			V
$R_{\theta CS}$	Case-To-Sink(Conductive Grease Applied)		0.1		$^\circ C/W$
M	Mounting Screw: M6	3.0		6.0	N·m
G	Weight		345		g

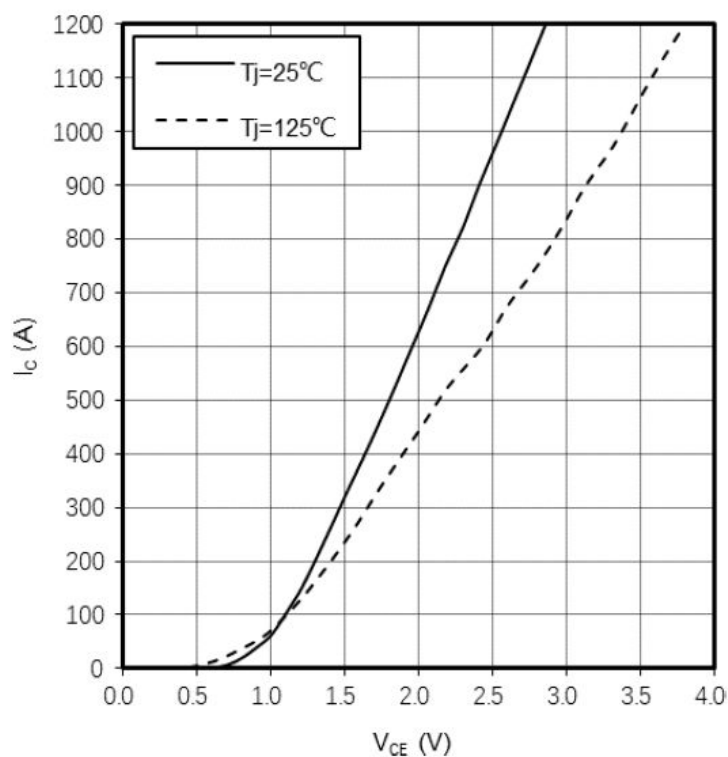


Fig 1. output characteristic IGBT, $I_c=f(V_{CE}), V_{GE}=15V$

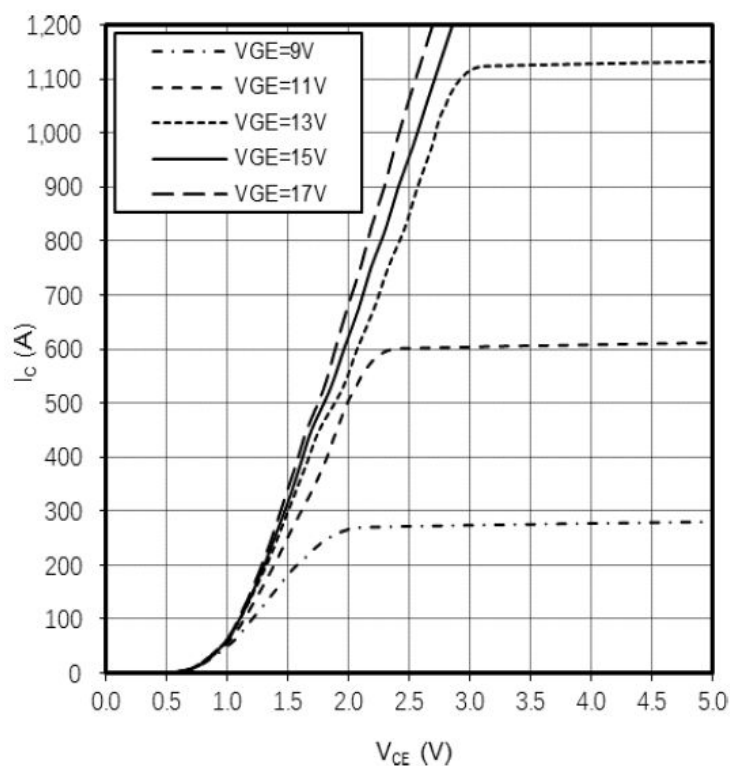


Fig 2. output characteristic IGBT, $I_c=f(V_{CE}), T_j=125^\circ C$

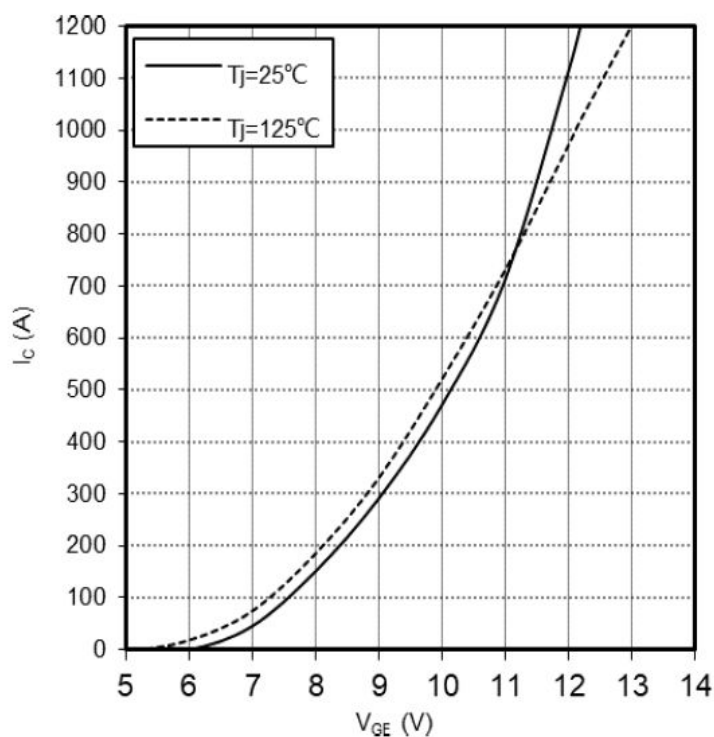


Fig 3. transfer characteristic IGBT, $I_c=f(V_{GE}), V_{CE}=20V$

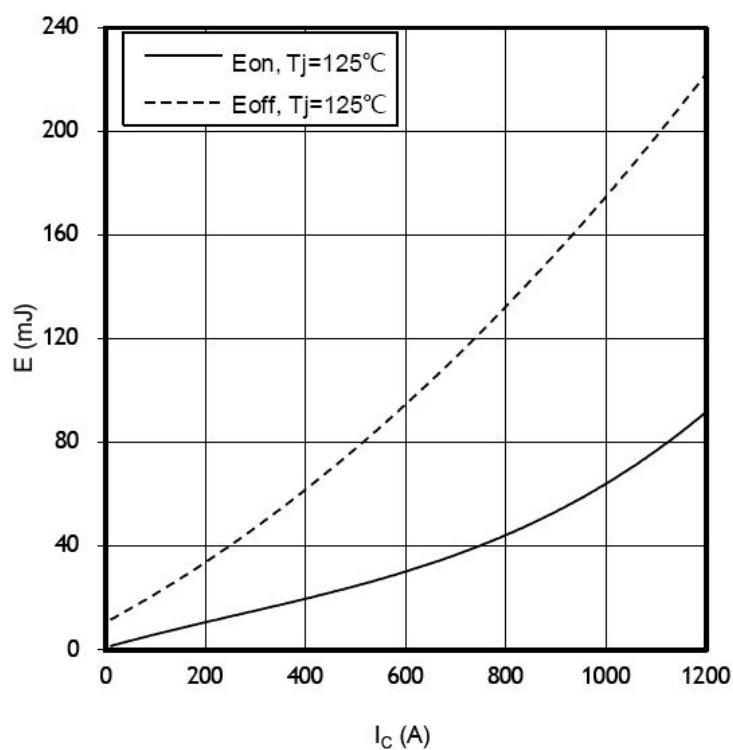


Fig 4. switching losses IGBT, $E_{on}=f(I_c), E_{off}=f(I_c)$,
 $V_{GE}=\pm 15V, R_{Gon}=1.3\Omega, R_{Goff}=1.3\Omega, V_{CE}=600V$

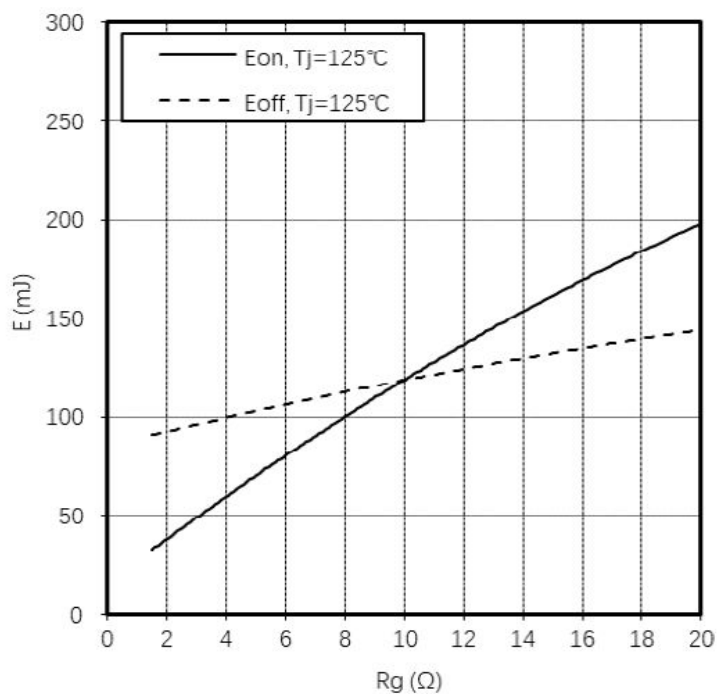


Fig 5. switching losses IGBT, $E_{on}=f(R_g)$, $E_{off}=f(R_g)$,
 $V_{GE}=\pm 15V$, $I_C=600A$, $V_{CE}=600V$

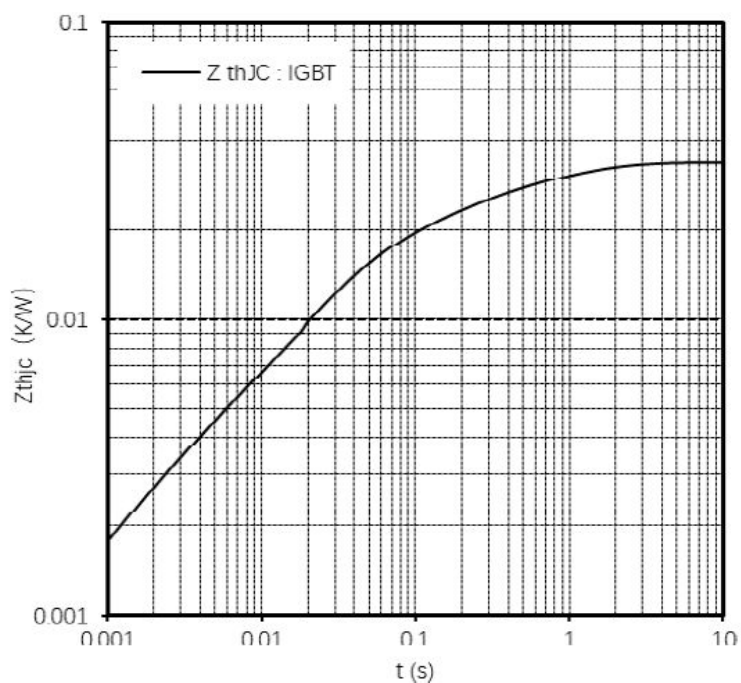


Fig 6. transient thermal impedance IGBT, $Z_{thjc}=f(t)$

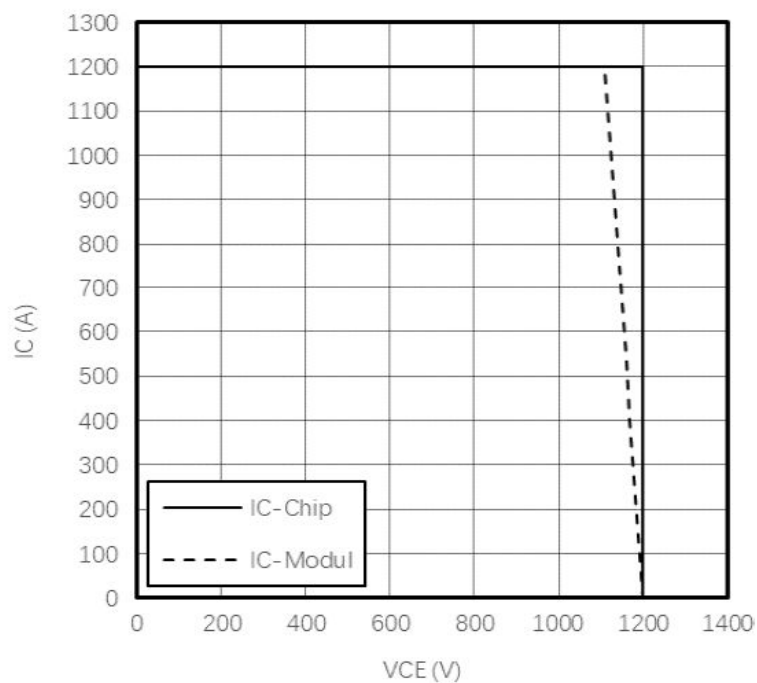


Fig 7. reverse bias safe operating area IGBT, $I_C=f(V_{CE})$,
 $V_{GE}=\pm 15V$, $R_{Goff}=1.3 \Omega$, $T_{vj}=125^\circ C$

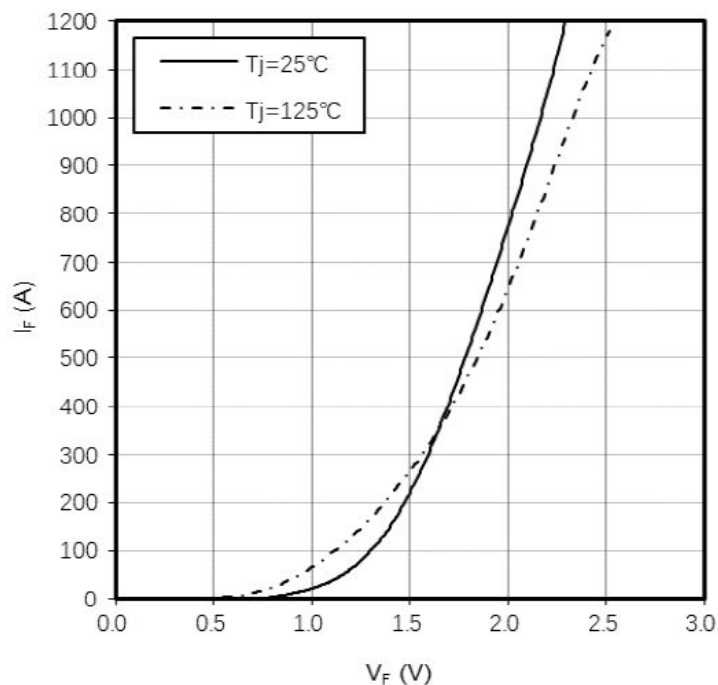


Fig 8. forward characteristic of Diode, $I_F=f(V_F)$

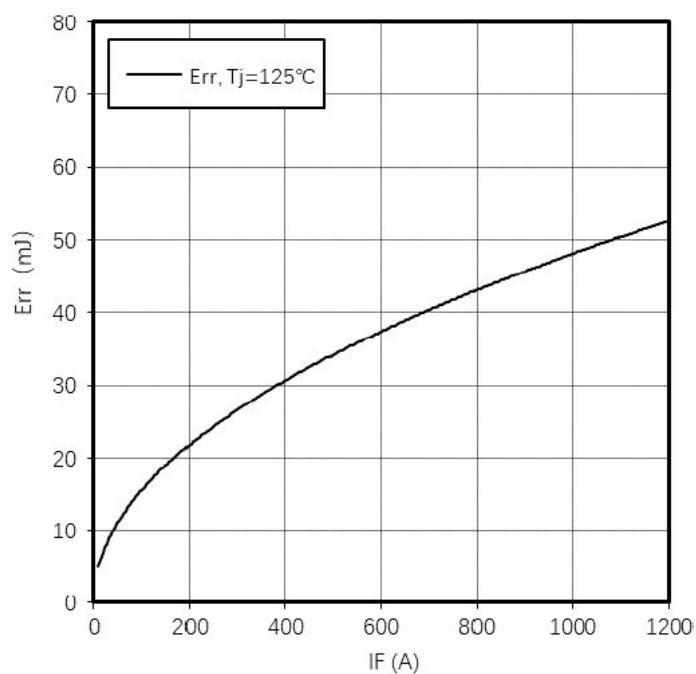


Fig 9. switching losses Diode, $E_{\pi}=f(I_F)$, $R_{Gon}=1.3 \Omega$, $V_{CE}=600V$

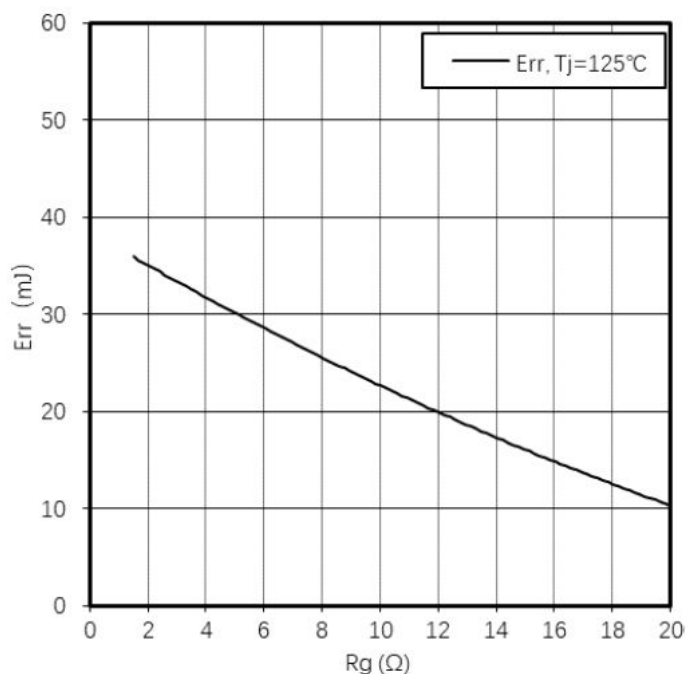


Fig 10. switching losses Diode, $E_{\pi}=f(R_G)$, $I_F=600A$, $V_{CE}=600V$

